# Designer's<sup>™</sup> Data Sheet TMOS E-FET ™ **High Energy Power FET N-Channel Enhancement-Mode Silicon** Gate

This advanced high voltage TMOS E-FET is designed to withstand high energy in the avalanche mode and switch efficiently. This new high energy device also offers a drain-to-source diode with fast recovery time. Designed for high voltage, high speed switching applications such as power supplies, PWM motor controls and other inductive loads, the avalanche energy capability is specified to eliminate the guesswork in designs where inductive loads are switched and offer additional safety margin against unexpected voltage transients.

- Avalanche Energy Capability Specified at Elevated Temperature
- Low Stored Gate Charge for Efficient Switching
- Internal Source-to-Drain Diode Designed to Replace External Zener screte Fast Transient Suppressor — Absorbs High Energy in the Avalanche Mode
- Source-to-Drain Diode Recovery Time Comparable to Discrete Fast Recovery Diode



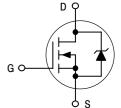
# **ON Semiconductor®**

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**TMOS POWER FET** 4.0 AMPERES, 500 VOLTS  $\mathbf{R}_{\mathrm{DS(on)}} = 1.5 \Omega$ 







Designer's Data for "Worst Case" Conditions — The Designer's Data Sheet permits the design of most circuits entirely from the information presented. SOA Limit curves - representing boundaries on device characteristics - are given to facilitate "worst case" design.

Preferred devices are Motorola recommended choices for future use and best overall value.

### MAXIMUM RATINGS (T<sub>C</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DSS</sub>	500	Vdc
Drain–Gate Voltage ( $R_{GS}$ = 1.0 M $\Omega$ )	V <sub>DGR</sub>	500	Vdc
Gate-Source Voltage — Continuous — Non-repetitive	V <sub>GS</sub> V <sub>GSM</sub>	±20 ±40	Vdc Vpk
Drain Current — Continuous — Pulsed	I <sub>D</sub> I <sub>DM</sub>	4.0 10	Adc
Total Power Dissipation @ T <sub>C</sub> = 25°C Derate above 25°C	P <sub>D</sub>	75 0.6	Watts W/°C
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C

## UNCLAMPED DRAIN-TO-SOURCE AVALANCHE CHARACTERISTICS (T<sub>d</sub> < 150°C)

- T <sub>J</sub> = 100°C Repetitive Pulse Drain-to-Source Avalanche Energy	W <sub>DSR</sub> (1) W <sub>DSR</sub> (2)	44 7.4	
THERMAL CHARACTERISTICS	-		

### **THERMAL CHARACTERISTICS**

Repetitive Pulse Drain-to-Source Avalanche Energy	W <sub>DSR</sub> (2)	7.4	
THERMAL CHARACTERISTICS			
Thermal Resistance — Junction to Case — Junction to Ambient	$R_{ extsf{ heta}JC}$ $R_{ extsf{ heta}JA}$	1.67 62.5	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	TL T	260	°C
<ul> <li>Junction to Ambient</li> <li>Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds</li> <li>(1) VDD = 50 V, ID = 4.0 A</li> <li>(2) Pulse Width and frequency is limited by TJ(max) and thermal response</li> </ul>	FORMA		

#### (1) $V_{DD} = 50 \text{ V}, I_D = 4.0 \text{ A}$

## ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

V <sub>(BR)DSS</sub>	500			Vdc
	500	_		Vdc
I <sub>DSS</sub>			0.25 1.0	mAdc
I <sub>GSSF</sub>	—	—	100	nAdc
I <sub>GSSR</sub>	_		100	nAdc
	I <sub>GSSF</sub>	I <sub>GSSF</sub> —	IGSSF — —	-         -         0.25           -         -         1.0           I <sub>GSSF</sub> -         100

ON CHARACTERISTIC	S:
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Gate Threshold Voltage $(V_{DS} = V_{GS}, I_D = 250 \ \mu Adc)$ $(T_J = 125^{\circ}C)$	V <sub>GS(t</sub>	) 2.0 1.5		4.0 3.5	Vdc
Static Drain–Source On–Resistance ( $V_{GS}$ = 10 Vdc, $I_D$ = 2.0 A)	R <sub>DS(or</sub>	ı) —	1.3	1.5	Ohm
$\label{eq:GS} \begin{array}{l} \text{Drain-Source On-Voltage (V_{GS}=10 \ Vdc)} \\ (I_D=4.0 \ Adc) \\ (I_D=2.0 \ A, \ T_J=100^\circ\text{C}) \end{array}$	VDS(or	))	30	7.5 6.0	Vdc
Forward Transconductance ( $V_{DS}$ = 15 Vdc, $I_D$ = 2.0 A)	9FS	1.5	<u>S</u> <u> </u>	—	mhos
DYNAMIC CHARACTERISTICS		<u> </u>			

Input Capacitance		C <sub>iss</sub> 77	5 — pF	
Output Capacitance	(V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0, f = 1.0 MHz)	C <sub>oss</sub> — 8	4 —	
Transfer Capacitance		C <sub>rss</sub> 1	9 —	
SWITCHING CHARACTERISTICS*				

#### SWITCHING CHARACTERISTICS\*

Turn-On Delay Time	5	t <sub>d(on)</sub>	I	24	_	ns
Rise Time		t <sub>r</sub>	_	34	_	
Turn-Off Delay Time	$V_{GS(on)} = 10 V$	t <sub>d(off)</sub>		60		
Fall Time		t <sub>f</sub>	_	36	_	
Total Gate Charge		Qg	_	27	32	nC
Gate-Source Charge	$(V_{DS} = 400 \text{ V}, I_D = 4.0 \text{ A}, V_{GS} = 10 \text{ V})$	Q <sub>gs</sub>	_	3.5		
Gate-Drain Charge		Q <sub>gd</sub>	_	14	_	

# SOURCE-DRAIN DIODE CHARACTERISTICS

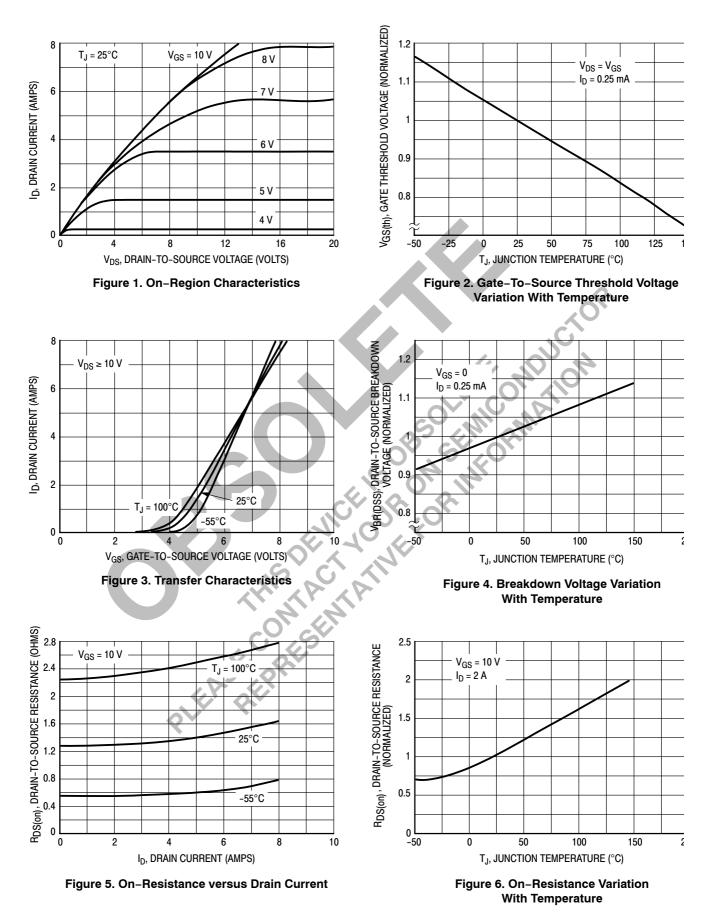
Forward On-Voltage	CO' CV'	V <sub>SD</sub>	_		1.4	Vdc
Forward Turn-On Time	(I <sub>S</sub> = 4.0 A, di/dt = 100 A/µs)	t <sub>on</sub>	_	**		ns
Reverse Recovery Time	SVOV	t <sub>rr</sub>	—	—	760	
INTERNAL PACKAGE INDUCTANC	NTERNAL PACKAGE INDUCTANCE					

Internal Drain Inductance (Measured from the contact screw on tab to center of die) (Measured from the drain lead 0.25" from package to center of die)	L <sub>d</sub>	 3.5 4.5	 nH
Internal Source Inductance (Measured from the source lead 0.25" from package to source bond pad)	L <sub>s</sub>	 7.5	

\*Indicates Pulse Test: Pulse Width = 300  $\mu$ s Max, Duty Cycle  $\leq$  2.0%.

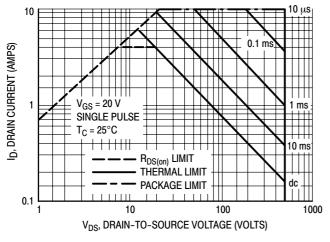
\*\* Limited by circuit inductance.

## **TYPICAL ELECTRICAL CHARACTERISTICS**



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## SAFE OPERATING AREA INFORMATION



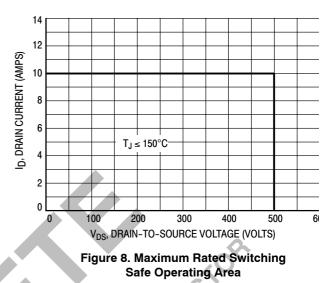


#### FORWARD BIASED SAFE OPERATING AREA

The FBSOA curves define the maximum drain-to-source voltage and drain current that a device can safely handle when it is forward biased, or when it is on, or being turned on. Because these curves include the limitations of simultaneous high voltage and high current, up to the rating of the device, they are especially useful to designers of linear systems. The curves are based on a case temperature of 25°C and a maximum junction temperature of 150°C. Limitations for repetitive pulses at various case temperatures can be determined by using the thermal response curves. Motorola Application Note, AN569, "Transient Thermal Resistance-General Data and Its Use" provides detailed instructions.

#### SWITCHING SAFE OPERATING AREA

The switching safe operating area (SOA) of Figure 8 is the boundary that the load line may traverse without incurring damage to the MOSFET. The fundamental limits are the peak current,  $I_{DM}$  and the breakdown voltage,  $V_{(BR)DSS}$ . The switching SOA shown in Figure 8 is applicable for both turn-on and turn-off of the devices for switching times less than one microsecond.



The power averaged over a complete switching cycle must be less than:

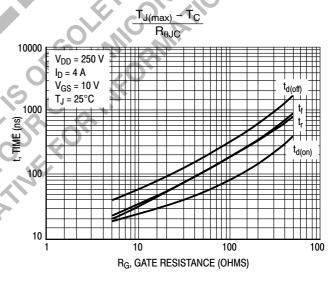
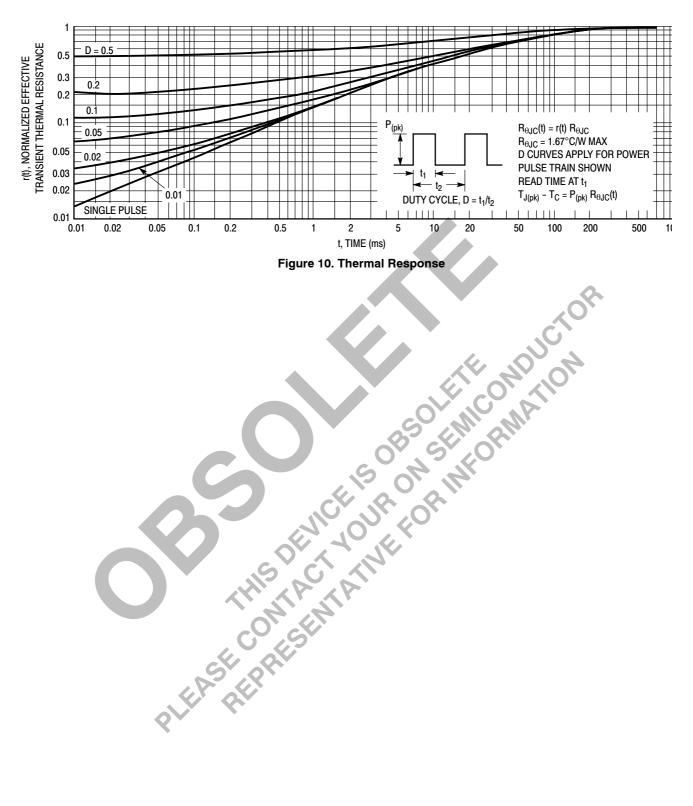
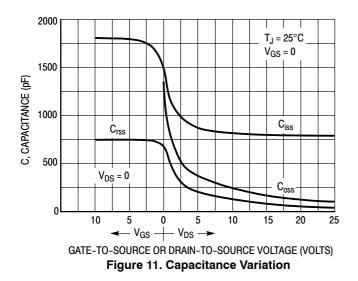
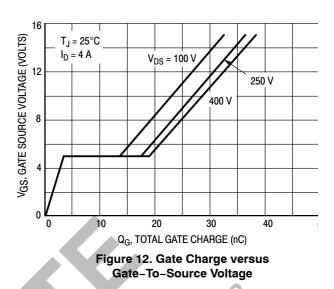


Figure 9. Resistive Switching Time Variation versus Gate Resistance







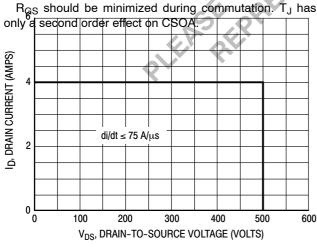
#### **COMMUTATING SAFE OPERATING AREA (CSOA)**

The Commutating Safe Operating Area (CSOA) of Figure 14 defines the limits of safe operation for commutated source-drain current versus re-applied drain voltage when the source-drain diode has undergone forward bias. The curve shows the limitations of  $I_{FM}$  and peak  $V_{DS}$  for a given rate of change of source current. It is applicable when waveforms similar to those of Figure 13 are present. Full or half-bridge PWM DC motor controllers are common applications requiring CSOA data.

Device stresses increase with increasing rate of change of source current so  $dI_{\rm s}/dt$  is specified with a maximum value. Higher values of  $dI_{\rm s}/dt$  require an appropriate derating of  $I_{FM}$ , peak  $V_{DS}$  or both. Ultimately  $dI_{\rm s}/dt$  is limited primarily by device, package, and circuit impedances. Maximum device stress occurs during  $t_{rr}$  as the diode goes from conduction to reverse blocking.

 $V_{DS(pk)}$  is the peak drain-to-source voltage that the device must sustain during commutation;  $I_{FM}$  is the maximum forward source-drain diode current just prior to the onset of commutation.

 $V_R$  is specified at 80% of  $V_{(BR)DSS}$  to ensure that the CSOA stress is maximized as  $I_S$  decays from  $I_{RM}$  to zero.





Stray inductances in Motorola's test circuit are assumed to be practical minimums.  $dV_{DS}/dt$  in excess of 10 V/ns was attained with  $dI_s/dt$  of 400 A/µs.

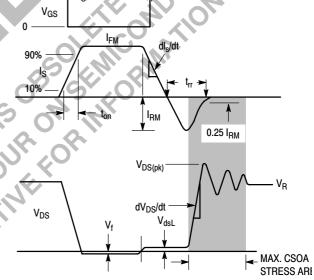
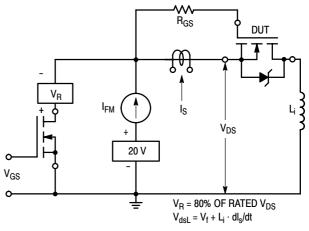
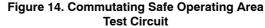
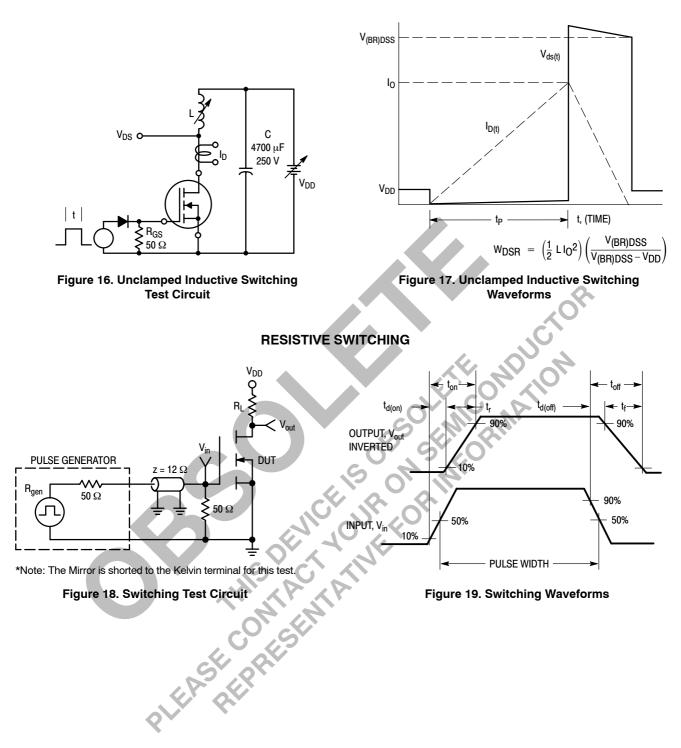
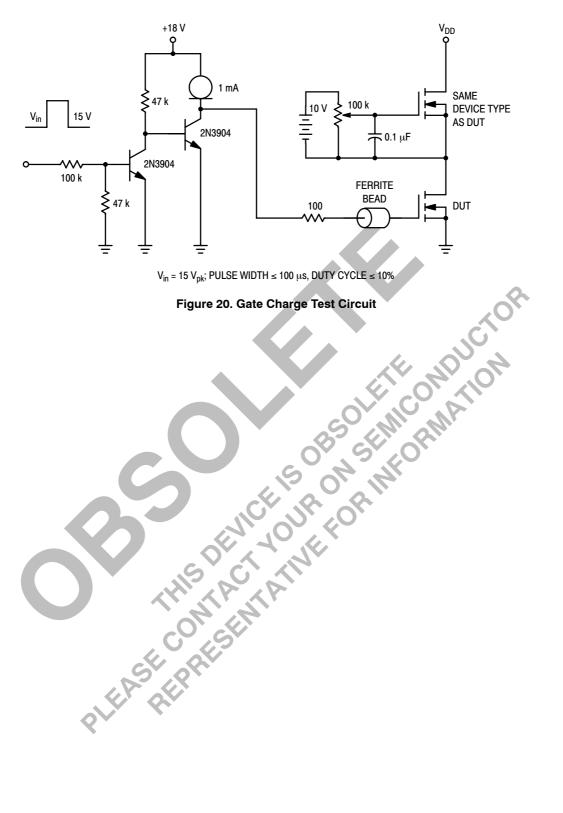


Figure 15. Commutating Waveforms



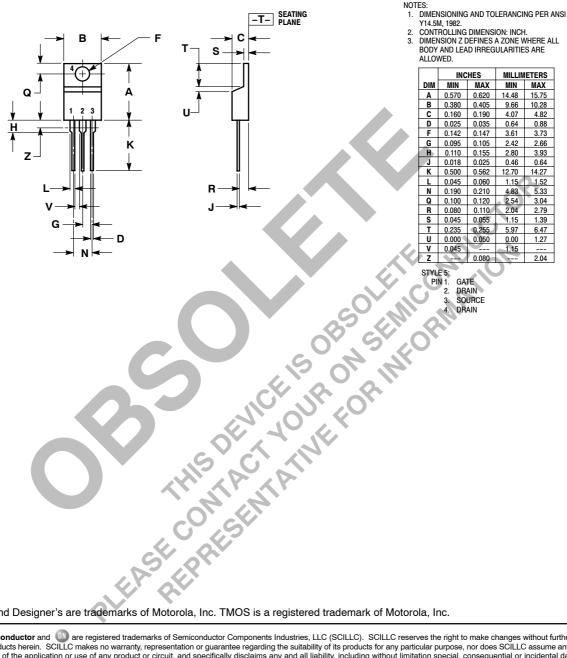






#### PACKAGE DIMENSIONS

#### CASE 221A-06 **ISSUE Y**



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